

Search Notes



Application/Control No.

10/735,532

Examiner

VINH P. NGUYEN

Applicant(s)/Patent under
Reexamination

CHAN ET AL.

Art Unit

2829

SEARCHED

Class	Subclass	Date	Examiner
324	140R-142 103R 107	03/03/05	VN
702	60		
330	127-129		
1	254 278		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search		VN